

Search Notes



Application/Control No.

10/773,044

Examiner

Hiep Nguyen

Applicant(s)/Patent under
Reexamination

HIROTSUGU ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	51	03.15.05	Mh
	52	T	T
	65		
	60		
	63		
	124		
	30		
360	46		
	67		
	68		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST See attachment	03.15.05	Mh
Consulted with Tham Lam	03.15.05	Mh
Consulted with Steve Mottola	03.15.05	Mh